

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/629,860	<b>Applicant(s)/Patent under Reexamination</b> EICH ET AL.
	<b>Examiner</b> Christine M. Behncke	<b>Art Unit</b> 3661

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner